


<b>Search Notes</b>  	<b>Application/Control No.</b>  10613497	<b>Applicant(s)/Patent Under Reexamination</b>  CHEN, TIENTEH
	<b>Examiner</b>  Shewareged, Betelhem	<b>Art Unit</b>  1794

SEARCHED			
Class	Subclass	Date	Examiner
	AS TO DATE	11/2007	BS
	AS TO DATE	4/2008	BS
	AS TO DATE	11/2008	BS

SEARCH NOTES			
Search Notes		Date	Examiner
WEST		11/2007	BS
AS TO DATE		4/2008	BS
AS TO DATE		11/2008	BS

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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